Notice of References Cited Application/Control No. 10/645,597 Examiner ANTHONY MEJIA Applicant(s)/Patent Under Reexamination KU, TSE-FEN Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,224,519 B1	05-2001	Doolittle, Matthew	482/98
*	В	US-6,231,481 B1	05-2001	Brock, Kurtis Barkley	482/8
*	C	US-2002/0042328 A1	04-2002	Yoo, Jae-Won	482/8
*	D	US-6,450,922 B1	09-2002	Henderson et al.	482/8
*	Е	US-6,601,016 B1	07-2003	Brown et al.	702/182
*	F	US-6,746,371 B1	06-2004	Brown et al.	482/8
*	G	US-2004/0171464 A1	09-2004	Ashby et al.	482/054
*	Ι	US-2004/0198555 A1	10-2004	Anderson et al.	482/008
*	I	US-2005/0071197 A1	03-2005	Goldberg, Jason	705/002
*	J	US-6,921,351 B1	07-2005	Hickman et al.	482/8
*	K	US-2005/0233861 A1	10-2005	Hickman et al.	482/008
*		US-2008/0171922 A1	07-2008	TELLER et al.	600/301
*	М	US-7,488,277 B1	02-2009	Knapp, Jeffrey M.	482/104

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.